

Notice of References Cited	Application/Control No. 10/525,341		Applicant(s)/Patent Under Reexamination VEVERKA ET AL.	
	Examiner Celia Chang		Art Unit 1625	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,074,928	07-2006	Lifshitz-Liron et al.	546/119
*	B	US-7,291,735	11-2007	Mukarram et al.	546/114
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO2005/012300	02-2005	WO	Mukarram et al.	-----Kirk Othmer
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Kirk-Othmer "Crystallization...." Kirk-Othmer encyclopedia of Chemical Technology. vo. 8, p.95-147 (2002)
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.